

Data sheet	
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TDA1544

Dual 16-bit low-noise DAC

FEATURES

- 16-bit resolution and 4 x oversampling
- High performance: low distortion, wide dynamic range and high signal-to-noise ratio
- Single 5 V power supply
- No external components required
- Adjustable bias current
- Japanese-input format: time multiplexed, two's complement, TTL

GENERAL DESCRIPTION

The TDA1544 is a dual 16-bit digital-to-analog converter (DAC) and is designed for use in hi-fi digital audio equipment.

ORDERING INFORMATION

EXTENDED TYPE NUMBER	PACKAGE			
	PINS	PIN POSITION	MATERIAL	CODE
TDA1544	8	DIL	plastic	SOT97
TDA1544T	16	mini-pack	plastic	SO16L;SOT162A

QUICK REFERENCE DATA

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
V _{DD}	supply voltage		3.0	5.0	8.0	V
I _{DD}	supply current		-	50	60	mA
I _{FS}	full scale output current		2.7	3.0	3.3	mA
THD	total harmonic distortion	including noise at 0 dB	-	-75	-70	dB
			-	0.018	0.032	%
THD	total harmonic distortion	including noise at -60 dB	-	-33	-23	dB
			-	2.2	7.9	%
t _{cs}	current settling time to ±1 LSB		-	0.5	-	µs
BR	input bit rate at data input		-	-	9.2	Mbits/s
f _{CLK}	clock frequency at clock input		-	-	9.2	MHz
S/N	signal-to-noise ratio		99	101	-	dB
TC _{FS}	full scale temperature coefficient	at analog outputs (AOL; AOR)	-	±500 x 10 ⁻⁶	-	K ⁻¹
T _{amb}	operating ambient temperature range		-30	-	+85	°C
P _{tot}	total power dissipation		-	250	-	mW
I _{bias}	bias current (adjustable)		-0.6	-	5.0	mA

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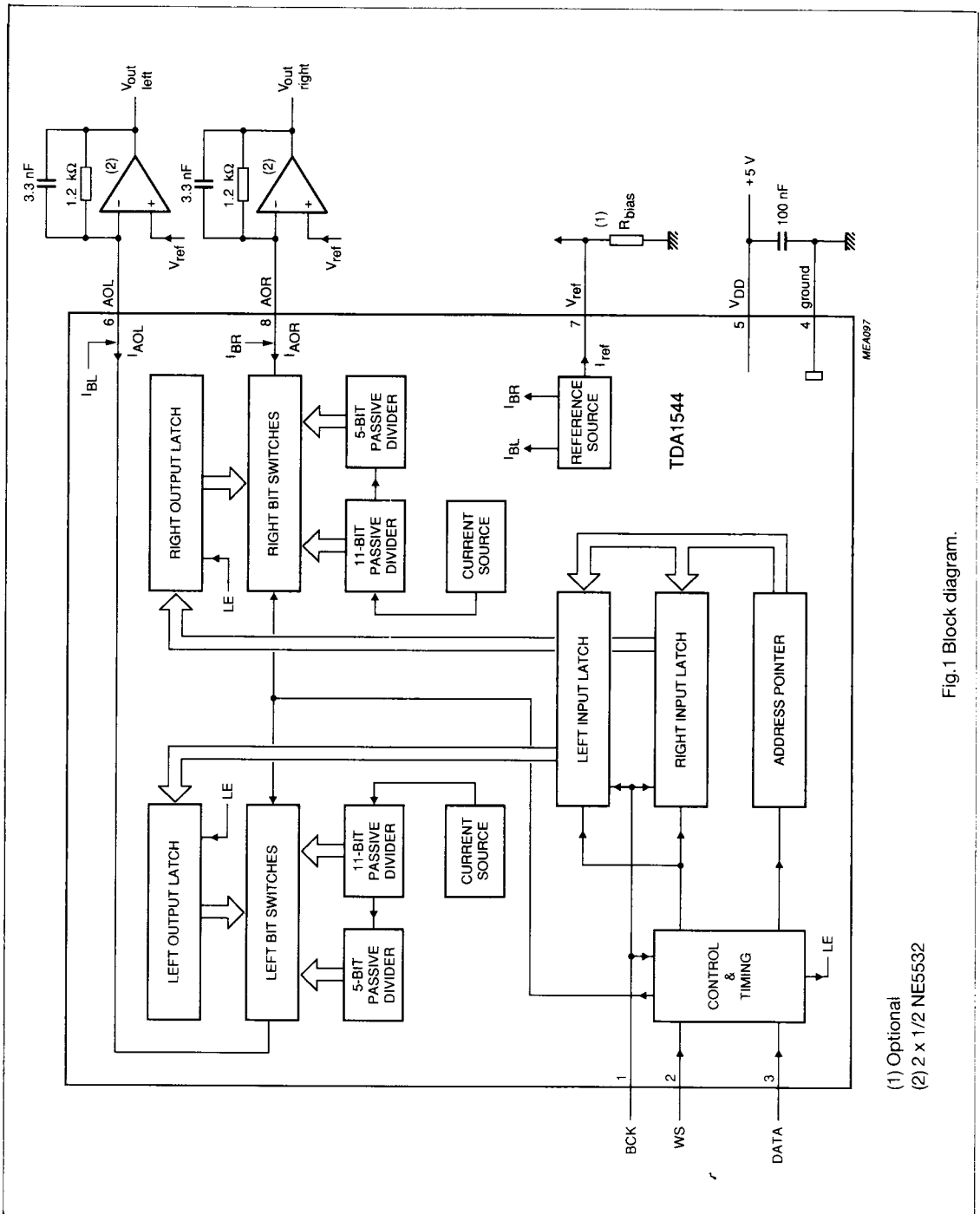


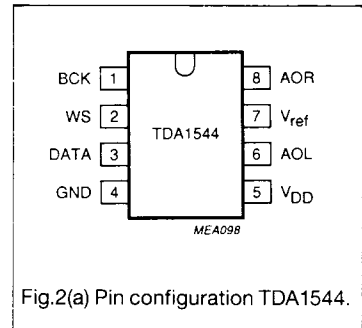
Fig.1 Block diagram.

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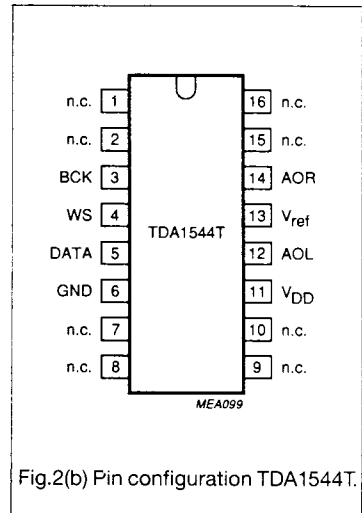
PINNING

SYMBOL	PIN	DESCRIPTION
BCK	1	bit clock input
WS	2	word select input
DATA	3	data input
GND	4	ground
V _{DD}	5	+5 V supply voltage
AOL	6	left channel output
V _{ref}	7	reference voltage output
AOR	8	right channel output



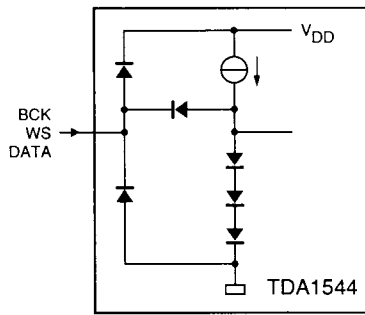
PINNING

SYMBOL	PIN	DESCRIPTION
n.c.	1	not connected
n.c.	2	not connected
BCK	3	bit clock input
WS	4	word select input
DATA	5	data input
GND	6	ground
n.c.	7	not connected
n.c.	8	not connected
n.c.	9	not connected
n.c.	10	not connected
V _{DD}	11	+5 V supply voltage
AOL	12	left channel output
V _{ref}	13	reference voltage output
AOR	14	right channel output
n.c.	15	not connected
n.c.	16	not connected

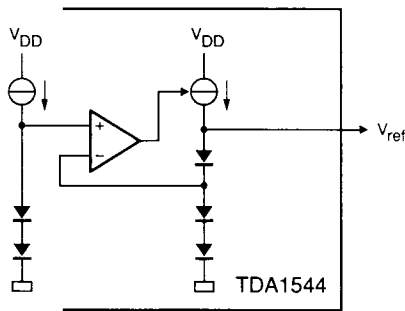


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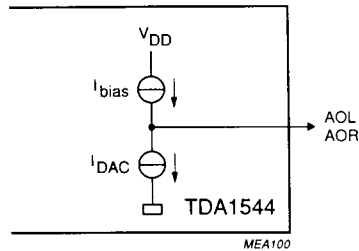
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(a) input pins BCK, WS and DATA.



(b) output pin V_{ref} .



(c) output pins AOL and AOR.

Fig.3 Circuits at the input and output pins.

Dual 16-bit low-noise DAC**TDA1544****FUNCTIONAL DESCRIPTION**

The TDA1544 accepts input serial data formats of 16-bit word length. Left and right data words are time multiplexed. The most significant bit (bit 1) must always be first. The format of data input is shown in Fig.4 and Fig.5.

The high maximum input bit-rate and fast settling current facilitates application in 4 x oversampling systems. An adjustable current is added to the output currents to bias output operational amplifiers (OP1; OP2) for maximum dynamic range (see Fig.1).

With a LOW level on the word select (WS) input data is placed in the right input register and with a HIGH level on the WS input data is placed in the left input register. The data in the input registers is simultaneously latched in the output registers which control the bit switches.

The output current of the DAC is a sink current. The current I_{ref} at the V_{ref} output is adjusted by a resistor or a current source. The current I_{ref} is amplified with gain A_{Ibias} to the bias currents (I_{BL} ; I_{BR}) which are added to the output currents.

LIMITING VALUES

Limiting values in accordance with the Absolute Maximum System (IEC 134)

SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT
V_{DD}	supply voltage range		0	9	V
T_{XTAL}	crystal temperature		-	+150	°C
T_{stg}	storage temperature range		-55	+150	°C
T_{amb}	operating ambient temperature range		-30	+85	°C
V_{es}	electrostatic handling*		-2000	+2000	V

THERMAL RESISTANCE

SYMBOL	PARAMETER	TYP.	UNIT
$R_{th\ j-a}$	from junction to ambient	100	K/W

* Equivalent to discharging a 100 pF capacitor through a 1.5 k Ω series resistor.

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CHARACTERISTICS

$V_{DD} = 5\text{ V}$; $T_{amb} = +25\text{ }^{\circ}\text{C}$; $I_{ref} = 0\text{ mA}$; measured in the circuit of Fig. 1; unless otherwise specified

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
Supply						
V_{DD}	supply voltage range		3.0	5.0	8.0	V
I_{DD}	supply current	note 1	-	50	60	mA
RR	ripple rejection	note 2	-	50	-	dB
Digital inputs						
I_{IL}	input current pins (1, 2 and 3) digital inputs LOW	$V_I = 0.8\text{ V}$	-	-	-0.4	mA
I_{IH}	digital inputs HIGH	$V_I = 2.0\text{ V}$	-	-	20	μA
f_{BCK}	input frequency/bit rate clock input pin 1		-	-	9.2	MHz
BR	bit rate data input pin 3		-	-	9.2	Mbits/s
f_{WS}	word select input pin 2		-	-	192	kHz
Analog outputs (AOL; AOR)						
Res	resolution		-	-	16	bits
$V_{OC(AC)}$	output voltage compliance AC		-	± 25	-	mV
$V_{OC(DC)}$	DC		1.8	-	$V_{DD}-1.2$	V
I_{FS}	full scale current		2.7	3.0	3.3	mA
T_{CFS}	full scale temperature coefficient		-	$\pm 500 \times 10^{-6}$	-	K^{-1}
I_{offset}	offset current	$I_{ref} = 0\text{ mA}$ $V_{AO} = V_{ref}$	-0.1	0.0	0.1	mA
I_{bias}	bias current (adjustable)		-0.6	-	5.0	mA
$A_{I_{bias}}$	bias current gain		0.95	1.00	1.05	
Analog outputs (V_{ref})						
V_{ref}	reference voltage output		2.05	2.20	2.35	V
I_{ref}	reference current output		-0.6	-	5.0	mA
THD	total harmonic distortion	including noise at 0 dB; note 3, Fig. 6		-75 0.018	-70 0.032	dB %
THD	total harmonic distortion	including noise at -60 dB; note 3, Fig. 6	- -	-33 2.2	-23 7.9	dB %
t_{cs}	settling time $\pm 1\text{ LSB}$		-	0.5	-	μs
α	channel separation		85	90	-	dB
$ d_{IO} $	unbalance between outputs	note 4	-	< 0.2	0.3	dB
$ t_d $	time delay between outputs		-	< 0.2	-	μs
S/N	signal-to-noise ratio at bipolar zero	note 5	99	101	-	dB

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SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
Timing (Fig.4)						
t_r	rise time		-	-	32	ns
t_f	fall time		-	-	32	ns
t_{CY}	bit clock cycle time		108	-	-	ns
t_{HB}	bit clock HIGH time		22	-	-	ns
t_{LB}	bit clock LOW time		22	-	-	ns
$t_{SU;DAT}$	data set-up time		32	-	-	ns
$t_{HD;DAT}$	data hold time to bit clock	note 6	2	-	-	ns
$t_{HD;WS}$	word select hold time	note 6	2	-	-	ns
$t_{SU;WS}$	word select set-up time		32	-	-	ns

Notes to the characteristics

1. Measured at $I_{AOL} = 0$ mA and $I_{AOR} = 0$ mA (code 8000H) and $I_{bias} = 0$ mA.
2. $V_{ripple} = 1\%$ of supply voltage and $f_{ripple} = 100$ Hz.
3. Measured with 1 kHz sinewave generated at a sampling rate of 192 kHz.
4. Measured with 1 kHz full scale sinewave generated at a sampling rate of 192 kHz.
5. At code 0000H.
6. At this point $t_{HD} = 0$ ns, this value has been fixed on 2 ns due to tolerances.

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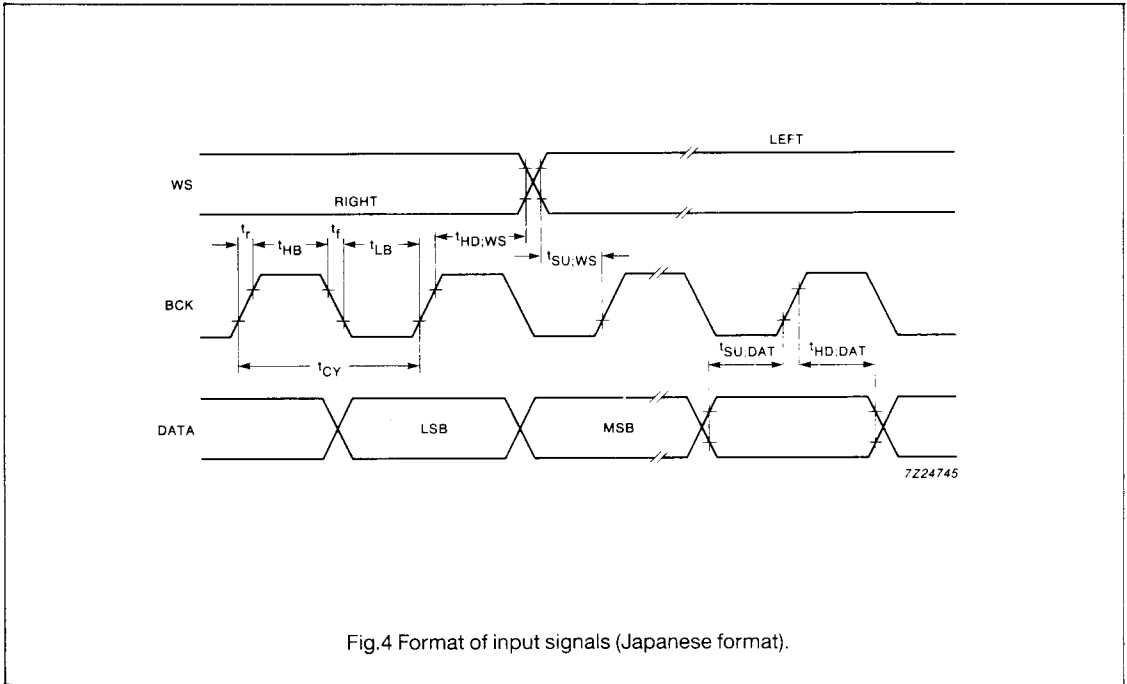


Fig.4 Format of input signals (Japanese format).

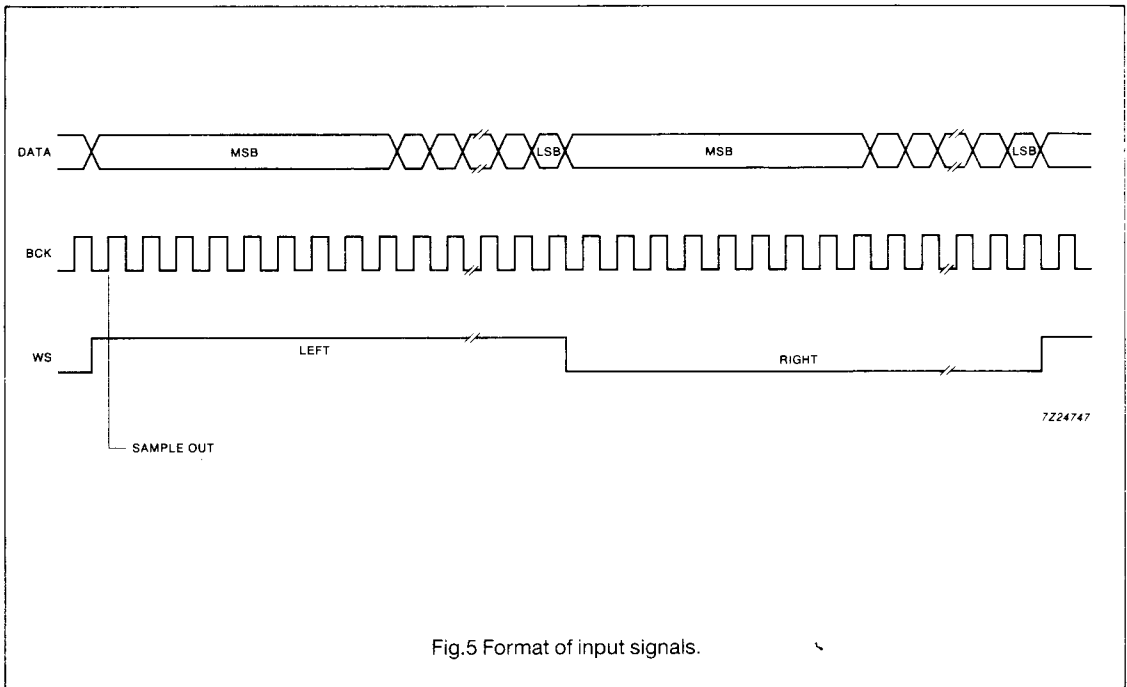
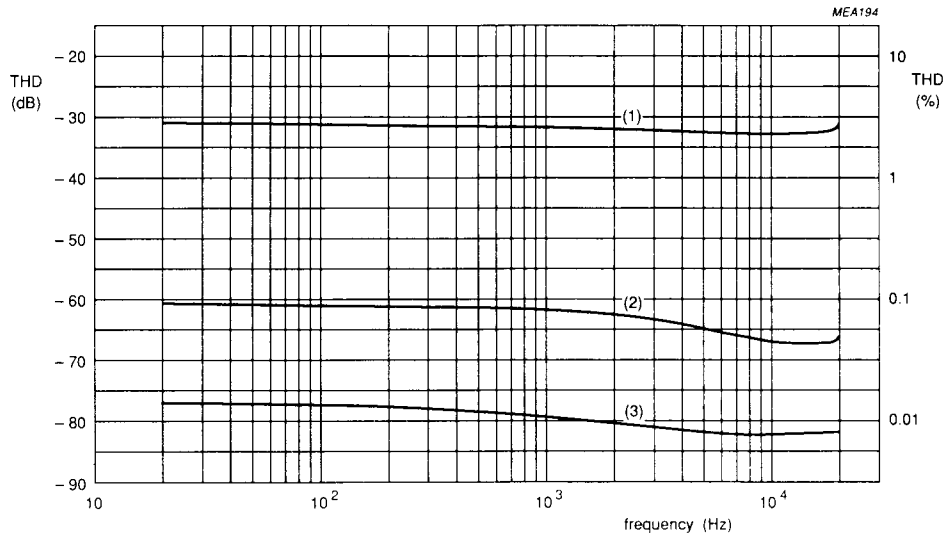


Fig.5 Format of input signals.

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- (1) Measured including all distortion plus noise over a 20 kHz bandwidth at a level of -60 dB
- (2) Measured including all distortion plus noise over a 20 kHz bandwidth at a level of -24 dB
- (3) Measured including all distortion plus noise over a 20 kHz bandwidth at a level of -0 dB

Fig.6 Distortion as a function of frequency (4FS)

Notes to Fig.6

- The sample frequency 4FS: 176.4 kHz.
- The supply voltage at the measurement = + 5 V (DC).
- Ref: 0 dB is the output level of a full scale digital sine wave stimulus.
- The graphs are constructed from average values of a small amount of engineering samples therefore no guarantee for typical values is implied.